#### **Features**

- Fast read access time 90ns
- Dual voltage range operation
  - Low voltage power supply range, 3.0V to 3.6V, or
  - Standard power supply range,  $5V \pm 10\%$
- Compatible with JEDEC standard Atmel<sup>®</sup> AT27C040
- Low-power, 3.3V CMOS operation
  - $-20\mu\text{A}$  max standby (less than  $1\mu\text{A}$ , typical) for  $V_{CC}=3.6\text{V}$
  - 36mW max active at 5MHz for  $V_{CC} = 3.6V$
- JEDEC-standard package
  - 32-lead PLCC
- High-reliability CMOS technology
  - 2,000V ESD protection
  - 200mA latchup immunity
- Rapid programming algorithm 100µs/byte (typical)
- CMOS- and TTL-compatible inputs and outputs
  - JEDEC standard for LVTTL
- Integrated product identification code
- Industrial temperature range
- Green (Pb/halide-free) packaging option

#### 1. Description

The Atmel AT27LV040A is a high-performance, low-power, low-voltage, 4,194,304-bit, one-time programmable, read-only memory (OTP EPROM) organized as 512K by 8 bits. It requires only one supply in the range of 3.0 to 3.6V in normal read mode operation, making it ideal for fast, portable systems using battery power.

The Atmel innovative design techniques provide fast speeds that rival 5V parts while keeping the low power consumption of a 3V supply. At  $V_{CC}=3.0V$ , any byte can be accessed in less than 90ns. With a typical power dissipation of only 18mW at 5MHz and  $V_{CC}=3.3V$ , the AT27LV040A consumes less than one-half the power of a standard, 5V EPROM. Standby mode supply current is typically less than  $1\mu A$  at 3.3V.

The AT27LV040A is available inan industry-standard, JEDEC-approved, one-time programmable (OTP) PLCC package. All devices feature two-line control ( $\overline{\text{CE}}$ ,  $\overline{\text{OE}}$ ) to give designers the flexibility to prevent bus contention.

The AT27LV040A operating with  $V_{CC}$  at 3.0V produces TTL-level outputs that are compatible with standard TTL logic devices operating at  $V_{CC}$  = 5.0V. The device is also capable of standard, 5V operation, making it ideally suited for dual supply range systems or card products that are pluggable in both 3V and 5V hosts.

The AT27LV040A has additional features to ensure high quality and efficient production use. The rapid programming algorithm reduces the time required to program the part and guarantees reliable programming. Programming time is typically only 100µs/byte. The integrated product identification code electronically identifies the device and manufacturer. This feature is used by industry standard programming equipment to select the proper programming algorithms and voltages. The AT27LV040A programs in exactly the same way as a standard, 5V Atmel AT27C040, and uses the same programming equipment.



4Mb (512K x 8) Low Voltage, One-time Programmable, Read-only Memory

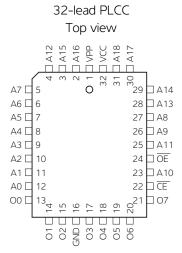
Atmel AT27LV040A





### 2. Pin configurations

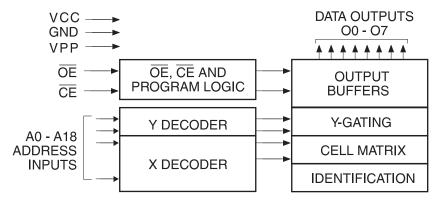
Pin name	Function
A0 - A18	Addresses
00 - 07	Outputs
Œ	Chip enable
ŌĒ	Output enable



#### 3. System considerations

Switching between active and standby conditions via the chip enable pin may produce transient voltage excursions. Unless accommodated by the system design, these transients may exceed datasheet limits, resulting in device nonconformance. At a minimum, a  $0.1\mu\text{F}$ , high-frequency, low inherent inductance, ceramic capacitor should be utilized for each device. This capacitor should be connected between the  $V_{CC}$  and ground terminals of the device, as close to the device as possible. Additionally, to stabilize the supply voltage level on printed circuit boards with large EPROM arrays, a  $4.7\mu\text{F}$  bulk electrolytic capacitor should be utilized, again connected between the  $V_{CC}$  and ground terminals. This capacitor should be positioned as close as possible to the point where the power supply is connected to the array.

Figure 3-1. Block diagram



#### 4. Absolute maximum ratings\*

Temperature under bias40°C to +85°C
Storage temperature65°C to +125°C
Voltage on any pin with respect to ground2.0V to +7.0V <sup>(1)</sup>
Voltage on A9 with respect to ground2.0V to +14.0V <sup>(1)</sup>
V <sub>PP</sub> supply voltage with respect to ground2.0V to +14.0V <sup>(1)</sup>

"NOTICE: Stresses beyond those listed under "Absolute maximum ratings" may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may

affect device reliability.

Note:

1. Minimum voltage is -0.6V DC, which may undershoot to -2.0V for pulses of less than 20ns. Maximum output pin voltage is  $V_{CC} + 0.75V$  DC, which may be exceeded if certain precautions are observed (consult application notes), and which may overshoot to +7.0V for pulses of less than 20ns.

### 5. DC and AC characteristics

Table 5-1. Operating modes

Mode/Pin	CE	ŌĒ	Ai	$V_{PP}$	V <sub>cc</sub>	Outputs
Read <sup>(2)</sup>	V <sub>IL</sub>	V <sub>IL</sub>	Ai	X <sup>(1)</sup>	V <sub>CC</sub>	D <sub>OUT</sub>
Output disable <sup>(2)</sup>	Х	V <sub>IH</sub>	X	Х	V <sub>CC</sub>	High Z
Standby <sup>(2)</sup>	V <sub>IH</sub>	Х	X	Х	V <sub>CC</sub>	High Z
Rapid program <sup>(3)</sup>	V <sub>IL</sub>	V <sub>IH</sub>	Ai	V <sub>PP</sub>	V <sub>CC</sub>	D <sub>IN</sub>
PGM verify <sup>(3)</sup>	Х	V <sub>IL</sub>	Ai	V <sub>PP</sub>	V <sub>CC</sub>	D <sub>OUT</sub>
PGM inhibit <sup>(3)</sup>	V <sub>IH</sub>	V <sub>IH</sub>	X	$V_{PP}$	V <sub>CC</sub>	High Z
Product identification <sup>(3)(5)</sup>	V <sub>IL</sub>	V <sub>IL</sub>	$A9 = V_{H}^{(4)}$ $A0 = V_{IH} \text{ or } V_{IL}$ $A1 - A18 = V_{IL}$	X	V <sub>CC</sub>	Identification code

Notes:

- 1. X can be  $V_{II}$  or  $V_{IH}$ .
- 2. Read, output disable, and standby modes require 3.0V  $\leq$  V<sub>CC</sub>  $\leq$  3.6V or 4.5V  $\leq$  V<sub>CC</sub>  $\leq$  5.5V.
- 3. Refer to programming characteristics. Programming modes require  $V_{CC} = 6.5V$ .
- 4.  $V_H = 12.0 \pm 0.5 V$ .
- 5. Two identifier bytes may be selected. All Ai inputs are held low  $(V_{IL})$  except A9, which is set to  $V_{H}$ , and A0, which is toggled low  $(V_{IL})$  to select the manufacturer's identification byte and high  $(V_{IH})$  to select the device code byte.

Table 5-2. DC and AC operating conditions for read operation

	Atmel AT27LV040A-90
Industrial operating temperature (case)	-40°C - 85°C
W. savagarah	3.0V to 3.6V
V <sub>CC</sub> power supply	5V ± 10%





Table 5-3. DC and operating characteristics for read operation

Symbol	Parameter	Condition	Min	Max	Units
V <sub>CC</sub> = 3.0V	to 3.6V				
I <sub>LI</sub>	Input load current	$V_{IN} = OV \text{ to } V_{CC}$		±1	μΑ
I <sub>LO</sub>	Output leakage current	$V_{OUT} = OV \text{ to } V_{CC}$		±5	μΑ
I <sub>PP1</sub> <sup>(2)</sup>	V <sub>PP</sub> <sup>(1)</sup> read/standby current	$V_{PP} = V_{CC}$		10	μΑ
1	v. (1)	$I_{SB1}$ (CMOS), $\overline{CE} = V_{CC\pm} 0.3V$		20	μΑ
I <sub>SB</sub>	V <sub>CC</sub> <sup>(1)</sup> standby current	$I_{SB2}$ (TTL), $\overline{CE} = 2.0 \text{ to } V_{CC} + 0.5V$		100	μΑ
I <sub>CC</sub>	V <sub>CC</sub> active current	$f = 5MHz$ , $I_{OUT} = 0mA$ , $\overline{CE} = V_{IL}$		10	mA
V <sub>IL</sub>	Input low voltage		-0.6	0.8	V
V <sub>IH</sub>	Input high voltage		2.0	V <sub>CC</sub> + 0.5	V
$V_{OL}$	Output low voltage	I <sub>OL</sub> = 2.0mA		0.4	V
V <sub>OH</sub>	Output high voltage	I <sub>OH</sub> = -2.0mA	2.4		V
$V_{CC} = 4.5V$	to 5.5V				
I <sub>LI</sub>	Input load current	$V_{IN} = 0V \text{ to } V_{CC}$		±1	μΑ
I <sub>LO</sub>	Output leakage current	$V_{OUT} = OV \text{ to } V_{CC}$		±5	μΑ
I <sub>PP1</sub> <sup>(2)</sup>	V <sub>PP</sub> <sup>(1)</sup> read/standby current	$V_{PP} = V_{CC}$		10	μΑ
1	V (1) standby current	$I_{SB1}$ (CMOS), $\overline{CE} = V_{CC} \pm 0.3V$		100	μΑ
I <sub>SB</sub>	V <sub>CC</sub> <sup>(1)</sup> standby current	$I_{SB2}$ (TTL), $\overline{CE}$ = 2.0 to $V_{CC}$ + 0.5V		1	mA
I <sub>CC</sub>	V <sub>CC</sub> active current	$f = 5MHz$ , $I_{OUT} = 0mA$ , $\overline{CE} = V_{IL}$		30	mA
V <sub>IL</sub>	Input low voltage		-0.6	0.8	V
V <sub>IH</sub>	Input high voltage		2.0	V <sub>CC</sub> + 0.5	V
V <sub>OL</sub>	Output low voltage	I <sub>OL</sub> = 2.1mA		0.4	V
V <sub>OH</sub>	Output high voltage	Ι <sub>ΟΗ</sub> = -400μΑ	2.4		V

Notes: 1.  $V_{CC}$  must be applied simultaneously with or before  $V_{PP}$ , and removed simultaneously with or after  $V_{PP}$ .

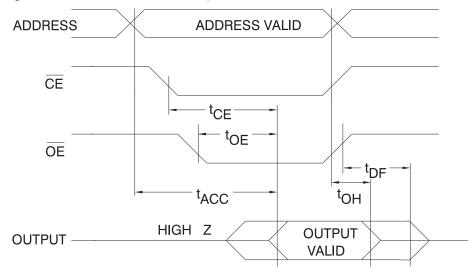
Table 5-4. AC characteristics for read operation

 $V_{CC}$  = 3.0V to 3.6V and 4.5V to 5.5V

			Atmel AT27LV040A-90		
Symbol	Parameter	Condition	Min	Max	Units
t <sub>ACC</sub> (3)	Address to output delay	$\overline{CE} = \overline{OE} = V_{IL}$		90	ns
t <sub>CE</sub> <sup>(2)</sup>	CE to output delay	OE = V <sub>IL</sub>		90	ns
t <sub>OE</sub> <sup>(2)(3)</sup>	OE to output delay	CE = V <sub>IL</sub>		50	ns
t <sub>DF</sub> <sup>(4)(5)</sup>	OE or CE high to output float, whichever occurred first			60	ns
t <sub>OH</sub>	Output hold from address, $\overline{CE}$ or $\overline{OE}$ , whichever occurred first		0		ns

<sup>2.</sup>  $V_{PP}$  may be connected directly to  $V_{CC}$ , except during programming. The supply current would then be the sum of  $I_{CC}$  and  $I_{PP}$ .

Figure 5-1. AC waveforms for read operation<sup>(1)</sup>



Notes:

- 1. Timing measurement references are 0.8V and 2.0V. Input AC drive levels are 0.45V and 2.4V. See input test waveforms and measurement levels.
- 2.  $\overline{\text{OE}}$  may be delayed up to  $t_{\text{CE}}$   $t_{\text{OE}}$  after the falling edge of  $\overline{\text{CE}}$  without impact on  $t_{\text{CE}}$ .
- 3.  $\overline{\text{OE}}$  may be delayed up to  $t_{\text{ACC}}$   $t_{\text{OE}}$  after the address is valid without impact on  $t_{\text{ACC}}$ .
- 4. This parameter is only sampled, and is not 100% tested.
- 5. Output float is defined as the point when data is no longer driven.

Figure 5-2. Input test waveforms and measurement level

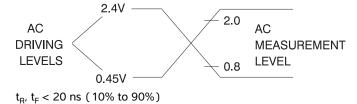
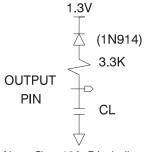


Figure 5-3. Output test load



Note: CL = 100pF including jig capacitance.



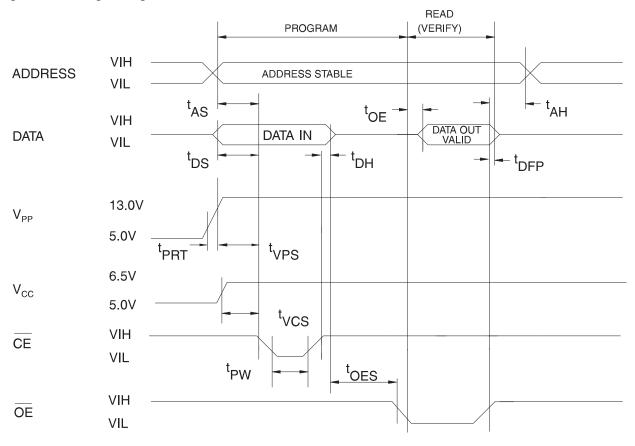


Table 5-5. Pin capacitance f = 1MHz,  $T = 25^{\circ}C^{(1)}$ 

Symbol	Тур	Max	Units	Conditions
C <sub>IN</sub>	4	8	pF	$V_{IN} = OV$
C <sub>OUT</sub>	8	12	pF	V <sub>OUT</sub> = 0V

Note: 1. Typical values for nominal supply voltage. This parameter is only sampled, and is not 100% tested.

Figure 5-4. Programming waveforms (1)



Note:

- 1. The input timing reference is 0.8V for  $\rm V_{IL}$  and 2.0V for  $\rm V_{IH}.$
- 2.  $t_{\text{OE}}$  and  $t_{\text{DFP}}$  are characteristics of the device, but must be accommodated by the programmer.
- 3. When programming the Atmel AT27LV040A, a  $0.1\mu F$  capacitor is required across  $V_{pp}$  and ground to suppress spurious voltage transients.

Table 5-6. DC programming characteristics

 $T_A = 25 \pm 5$ °C,  $V_{CC} = 6.5 \pm 0.25$ V,  $V_{PP} = 13.0 \pm 0.25$ V

			Limits		
Symbol	Parameter	Test conditions	Min	Max	Units
ILI	Input load current	V <sub>IN</sub> =V <sub>IL</sub> ,V <sub>IH</sub>		±10	μΑ
V <sub>IL</sub>	Input low level		-0.6	0.8	V
V <sub>IH</sub>	Input high level		2.0	V <sub>CC</sub> + 0.5	V
V <sub>OL</sub>	Output low voltage	I <sub>OL</sub> = 2.1mA		0.4	V
V <sub>OH</sub>	Output high voltage	I <sub>OH</sub> = -400μA	2.4		V
I <sub>CC2</sub>	V <sub>CC</sub> supply current (program and verify)			40	mA
I <sub>PP2</sub>	V <sub>pp</sub> supply current	$\overline{CE} = V_{IL}$		20	mΑ
V <sub>ID</sub>	A9 product identification voltage		11.5	12.5	V

Table 5-7. AC programming characteristics

 $T_A = 25 \pm 5$ °C,  $V_{CC} = 6.5 \pm 0.25$ V,  $V_{PP} = 13.0 \pm 0.25$ V

			Lin	nits	
Symbol	Parameter	Test conditions <sup>(1)</sup>	Min	Max	Units
t <sub>AS</sub>	Address setup time		2		μs
t <sub>OES</sub>	OE setup time	langet vice and fall times	2		μs
t <sub>DS</sub>	Data setup time	Input rise and fall times (10% to 90%) 20ns	2		μs
t <sub>AH</sub>	Address hold time	Input pulse levels  .0.45V to 2.4V	0		μs
t <sub>DH</sub>	Data hold time		2		μs
t <sub>DFP</sub>	OE high to output float delay <sup>(2)</sup>		0	130	ns
t <sub>VPS</sub>	V <sub>PP</sub> setup time	Input timing reference level	2		μs
t <sub>VCS</sub>	V <sub>CC</sub> setup time	0.8V to 2.0V	2		μs
t <sub>PW</sub>	CE program pulse width <sup>(3)</sup>	Output timing reference level 0.8V to 2.0V	95	105	μs
t <sub>OE</sub>	Data valid from $\overline{\text{OE}}^{(2)}$			150	ns
t <sub>PRT</sub>	V <sub>PP</sub> pulse rise time during programming		50		ns

Notes:

- 1.  $V_{CC}$  must be applied simultaneously with or before  $V_{PP}$  and removed simultaneously with or after  $V_{PP}$ .
- 2. This parameter is only sampled, and is not 100% tested. Output float is defined as the point where data is no longer driven. See timing diagram.
- 3. Program pulse width tolerance is  $100\mu \sec \pm 5\%$ .

Table 5-8. The Atmel AT27LV040A integrated product identification code (1)

		Pins								
Codes	A0	07	O6	O5	04	О3	02	01	00	Hex data
Manufacturer	0	0	0	0	1	1	1	1	0	1E
Device type	1	0	0	0	0	1	0	1	1	OB

Note: 1. The Atmel AT27LV040A has the same product identification code as the Atmel AT27C040. Both are programming compatible.

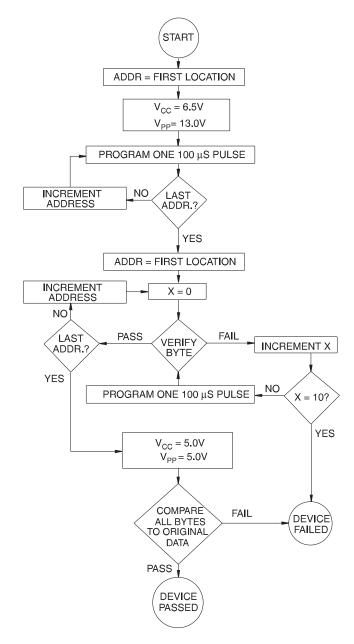




#### 6. Rapid programming algorithm

A 100 $\mu$ s  $\overline{\text{CE}}$  pulse width is used to program. The address is set to the first location.  $V_{CC}$  is raised to 6.5V and  $V_{PP}$  is raised to 13.0V. Each address is first programmed with one 100 $\mu$ s  $\overline{\text{CE}}$  pulse without verification. Then a verification/reprogramming loop is executed for each address. In the event a byte fails to pass verification, up to 10 successive 100 $\mu$ s pulses are applied with a verification after each pulse. If the byte fails to verify after 10 pulses have been applied, the part is considered failed. After the byte verifies properly, the next address is selected until all have been checked.  $V_{PP}$  is then lowered to 5.0V and  $V_{CC}$  to 5.0V. All bytes are read again and compared with the original data to determine if the device passes or fails.

Figure 6-1. Rapid programming algorithm



# 7. Ordering information

Green package option (Pb/halide-free)

t <sub>ACC</sub>	I <sub>CC</sub> (mA) V <sub>CC</sub> = 3.6V					
(ns)	Active	Standby	Atmel ordering code	Package	Lead finish	Operation range
90	8	0.02	AT27LV040A-90JU	32J	Matte tin	Industrial (-40°C to 85°C)

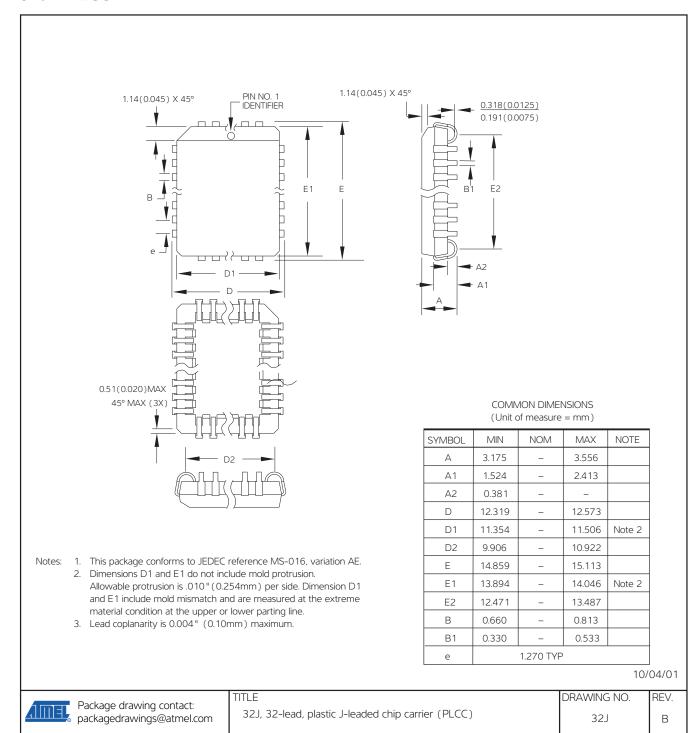
	Package type
32J	32-lead, plastic, J-leaded chip carrier (PLCC)





### 8. Packaging information

#### 32J – PLCC



# 9. Revision history

Doc. rev.	Date	Comments
0557E	04/2011	Remove TSOP and VSOP packages
		Add lead finish to ordering information
0557D	12/2007	





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